Search Notes

Application/Control No.	on/Control No. Applicant(s)/Patent under Reexamination	
10/770,074	HAY, JENNIFER	
Examiner	Art Unit	
Toan M. Le	2863	

SEARCHED				
Class	Subclass	Date	Examiner	
702	179	5/27/2005	TL	
702	189	5/27/2005	TL	
73	78	5/31/2005	TL	
73	85	5/31/2005	TL	
73	81	5/31/2005	TL	
		*		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				
	<u> </u>			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Indenter, Hardness, Stress, Strain, Force	5/27/2005	TL
Indenter, Hardness, Setup, Point, Engagement, Profile, Deviation	5/31/2005	TL
Indenter, Multiple Standard Deviation	6/2/2005	TL
Indenter, Compensation, Standard Deviation	6/3/2005	TL
East, Web, and NPL search		